

LCLS-II Undulator Segment Measurement Results

HXU-027

LCLS-II HXU Measurement Results

This report is intended to document the results of HXU segment tuning at LBNL and ANL. It should be sent to SLAC for approval before the HXU segment gets shipped.

Serial number from manufacturer's label:	HXU-027
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Measurement Procedure:

The measurements have been carried out after the undulator segment had been fully tuned according to "LCLS-II Undulator Test Plan" (LCLS-TN-17-1).

General Hall Probe Scan Evaluation Parameters	S	
Undulator Temperature (should be 20.0)	20.24± 0.04	°C
First core pole # (count includes zero potential pole)	8	
Last core pole # (count includes zero potential pole)	253	
Tuning Gap	8.9999	mm
Evaluation of Hall Probe Scans at <u>Commissionin</u>	ng Gap	
Commissioning Gap Temperature (should be 20.0)	20.28± 0.05	°C
rms(B _{pk} /< B _{pk} > - 1)	0.00143	
K _{eff} at Commissioning Gap (should be 2.3400)	2.3399	
Commissioning Gap	7.9241	mm
I1X (over 4.012667 m) (should be within ± 40)	-10	μTm
I2X (over 4.012667 m) (should be within ± 150)	-15	μTm^2
I1Y (over 4.012667 m) (should be within ± 40)	10	μTm
I2Y (over 4.012667 m) (should be within ± 150)	44	μTm^2
Phase Shake (rms phase fluctuations over core poles) (<4.0)	2.41	degXray
Cell Phase Advance (over 4.012667 m)	486,601.0 (135×360+1.03)	degXray
Undulator Entrance Phase ¹	2,251.0 (25×90+1.03)	degXray
Undulator Exit Phase ²	2,250.0 (25×90+0.00)	degXray

¹ Phase advance from cell start (undulator center -2.006334 m) to center of physical pole 8.

² Phase advance from physical pole 253 to cell end (undulator center + 2.006334 m).



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Undulator Encoder Settings

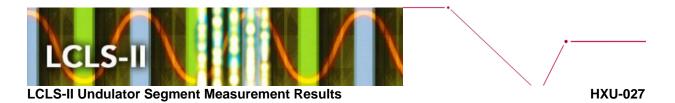
USGapEncoderOffset	NA
DSGapEncoderOffset	NA
USWLinearEncoder.AOFF	89.2196
DSWLinearEncoder.AOFF	89.0551
USALinearEncoder.AOFF	92.4052
DSALinearEncoder.AOFF	90.4576

Undulator Load Cell Readings at Tuning Gap (Gap Opening)

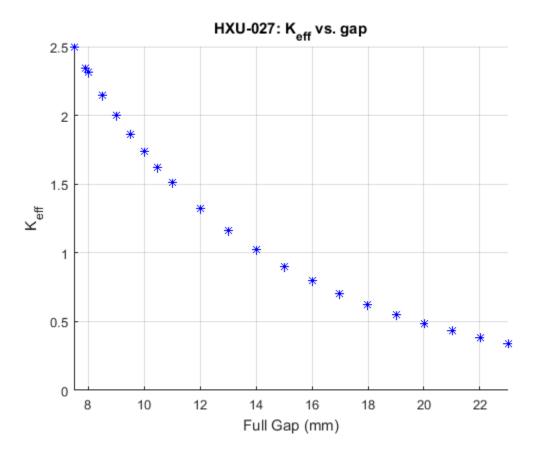
LC_DAL_	FORCE	-298.7
LC_DAU	FORCE	-271.4
LC_DWL	_FORCE	-270.4
LC_DWU	_FORCE	-294.6
LC_UAL_	FORCE	-286.3
LC_UAU	FORCE	-299.7
LC_UWL	_FORCE	-153.5
LC_UWU	_FORCE	-299.7

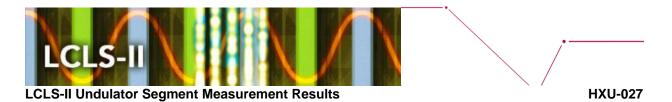
Undulator Load Cell Readings at 100 mm Gap (Gap Opening)

LC_DAL_FORCE	1.0
LC_DAU_FORCE	0.0
LC_DWL_FORCE	0.0
LC_DWU_FORCE	0.0
LC_UAL_FORCE	1.0
LC_UAU_FORCE	-2.0
LC_UWL_FORCE	-1.0
LC_UWU_FORCE	-2.0

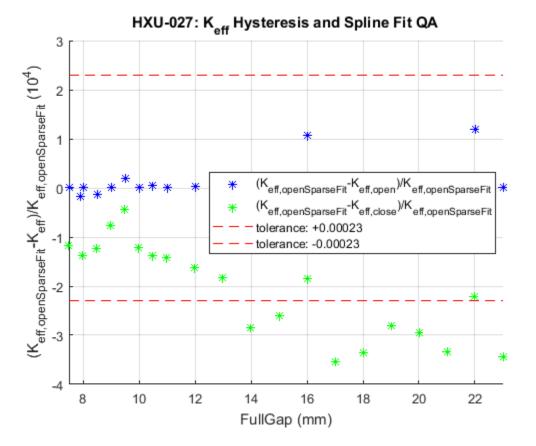


Evaluation of Hall Probe Scans: *K_{eff}* vs *gap*



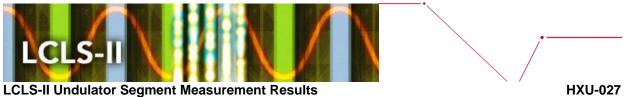


Evaluation of Hall Probe Scans: *K_{eff}* Hysteresis using Half Gap Encoders



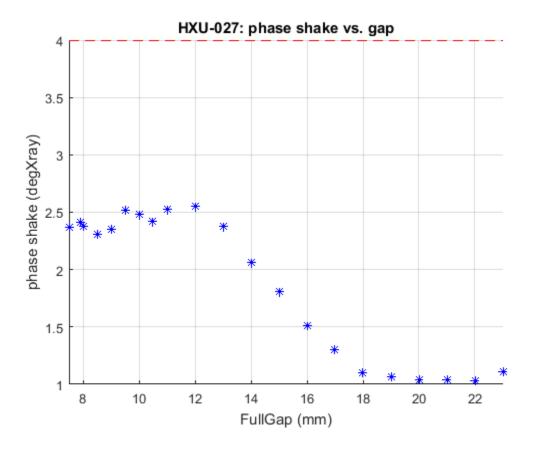
Plotted functions have been calculated from measured values openKeff (opengap) and closeKeff (closegap) using the following Matlab calculations:

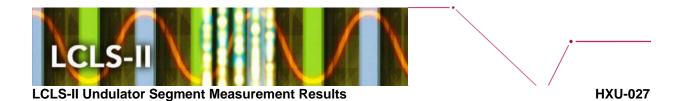
Blue Stars: 1-openKeff./ spline(opengap(1:2:end),openKeff(1:2:end),opengap) Green Stars: 1-closeKeff./ spline(opengap(1:2:end),openKeff(1:2:end),closegap)



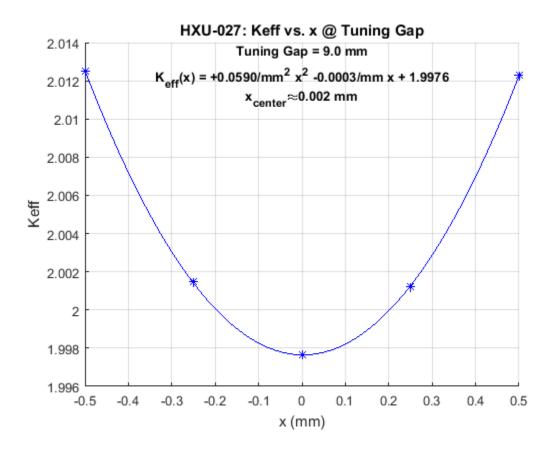
Evaluation of Hall Probe: Phase Shake vs. gap

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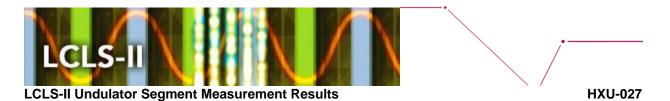




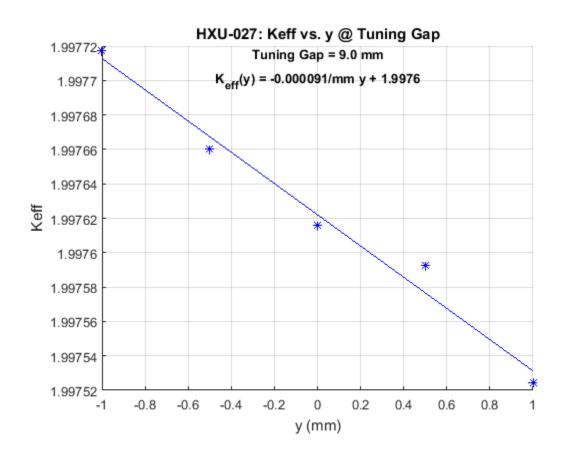
Evaluation of Hall Probe: *K_{eff}* vs x at Tuning Gap

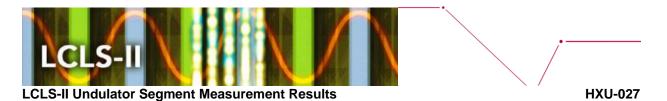


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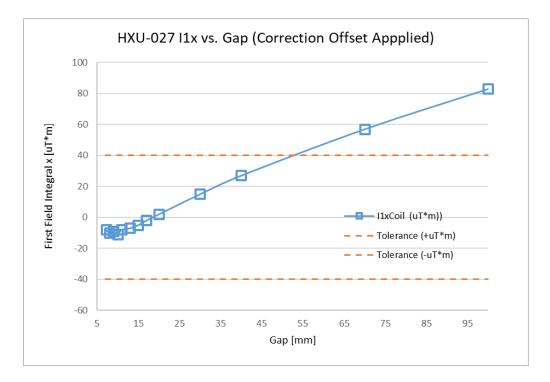


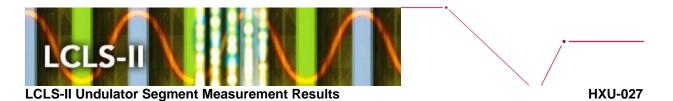
Evaluation of Hall Probe: Keff vs y at Tuning Gap



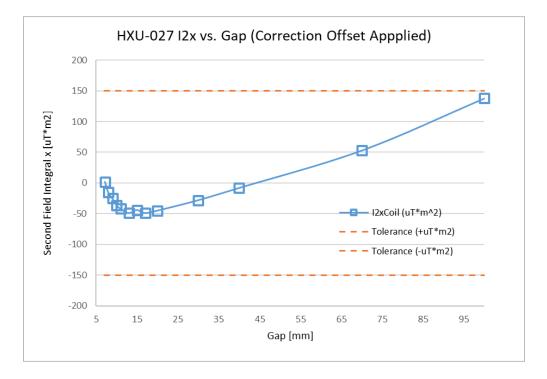


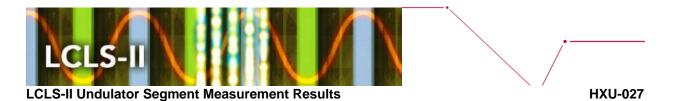
Long Coil Measurement of the On-Axis First Horizontal Field Integrals with +30 μ T·m Integral Offset



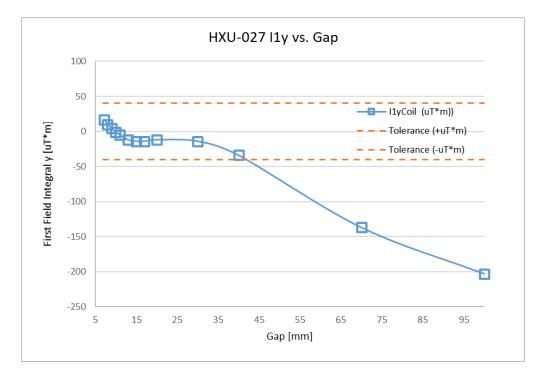


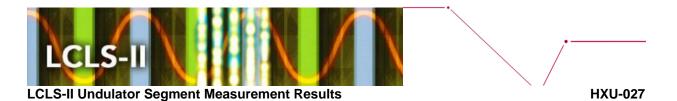
Long Coil Measurement of the On-Axis Second Horizontal Field Integrals with +30 μ T·m x 0.5 x 4.012667 m Second Integral Offset



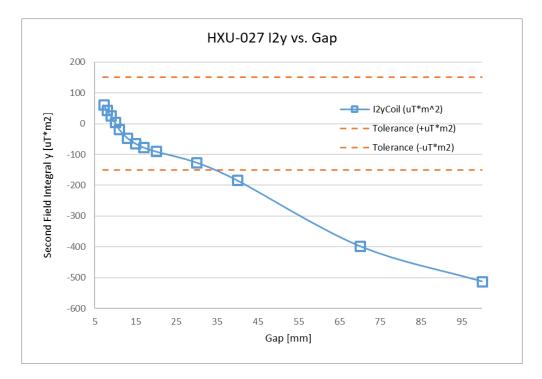


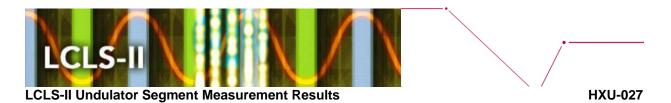
Long Coil Measurement of the On-Axis First Vertical Field Integrals



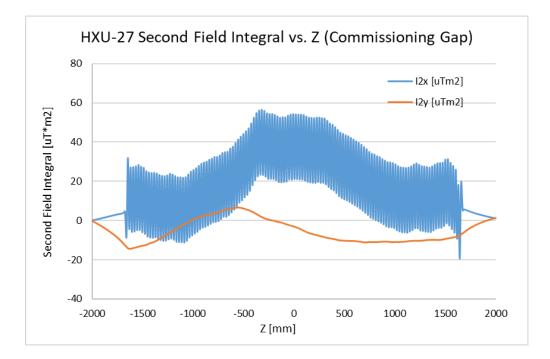


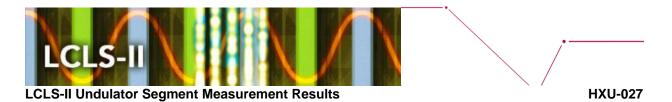
Long Coil Measurement of the On-Axis Second Vertical Field Integrals



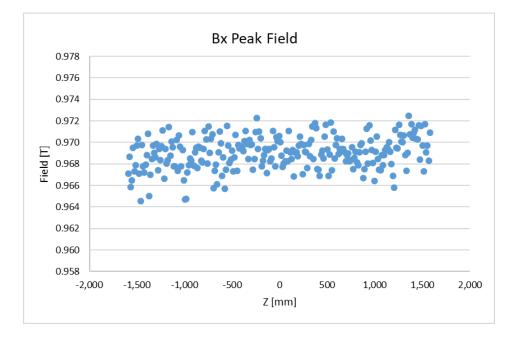


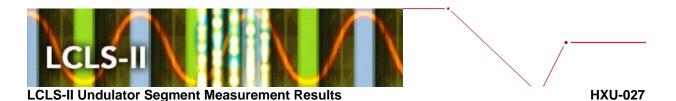
Second Horizontal and Vertical Field Integrals along Undulator Length at Commissioning Gap



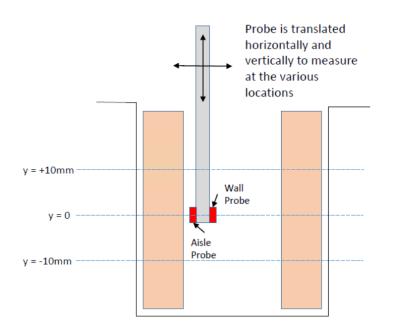


Horizontal Peak Field along Undulator Length at Commissioning Gap

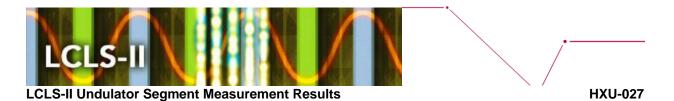




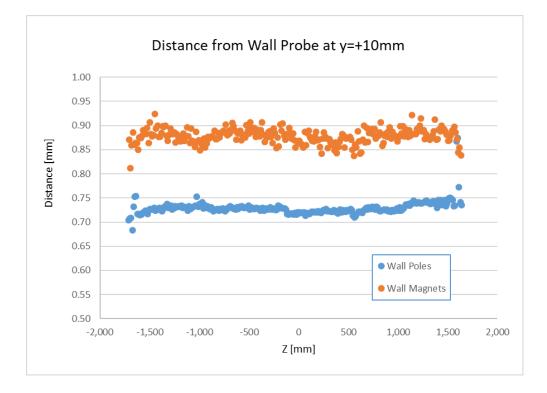
Capacitive Sensor Arrangement

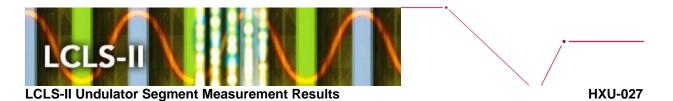


The following plots show the pole and magnet position measurements. The ANL system has two back-to-back capacitive probes on one probe holder. The x and y stages on the 6-meter bench are positioned so that the probe is in the proper location for each of the 9 scan locations. For the data analysis, the average pole position in each scan is used as reference for the plotted pole and magnet positions. Note that for all plots, the first three and last three poles of the device are omitted since the measurement is not accurate due to end effects in the capacitance probe measurement.

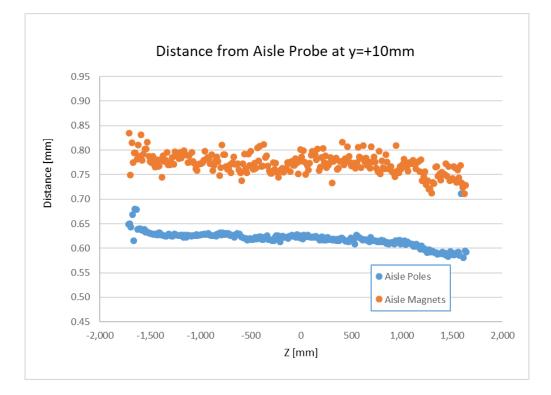


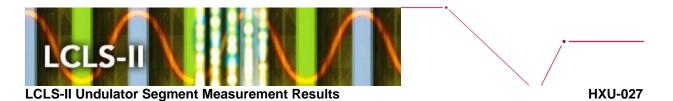
Aisle Capacitive Sensor Readings y = +10mm



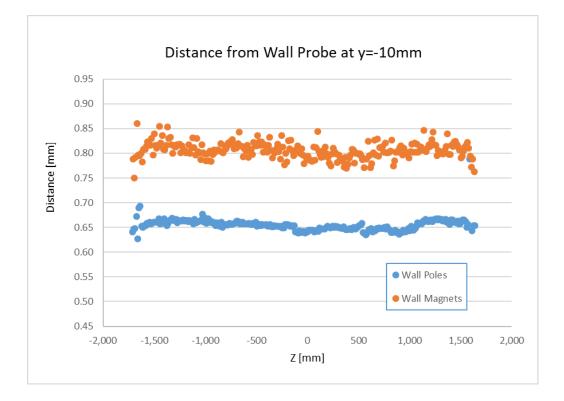


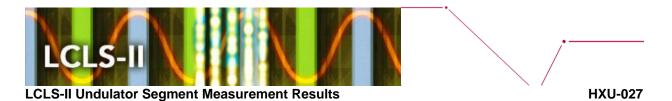
Wall Capacitive Sensor Readings y = +10mm



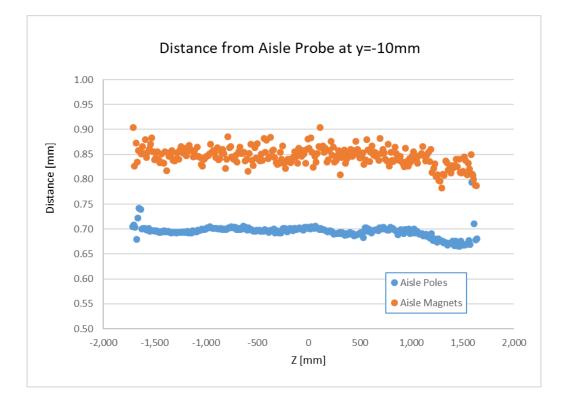


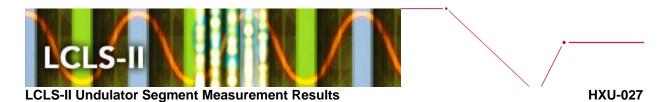
Aisle Capacitive Sensor Readings y = -10mm



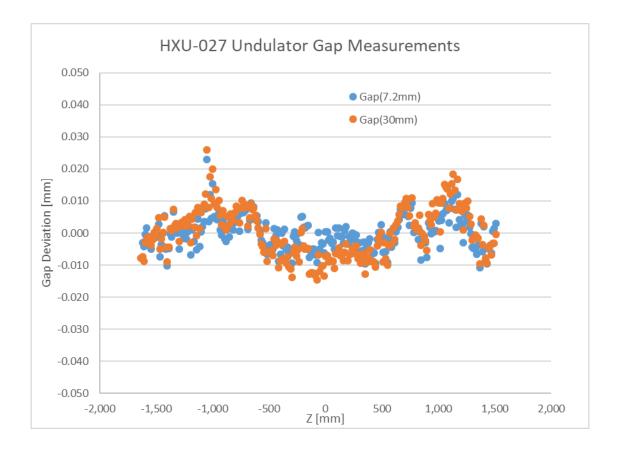


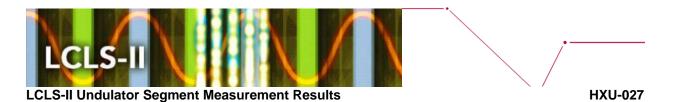
Wall Capacitive Sensor Readings y = -10mm



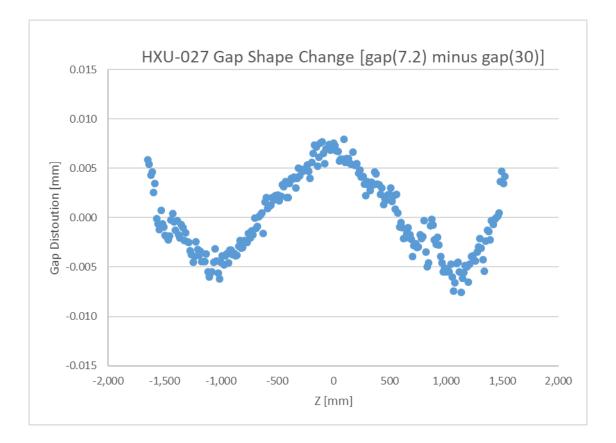


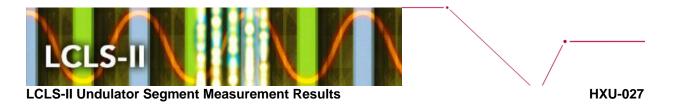
Undulator Gap Measurements



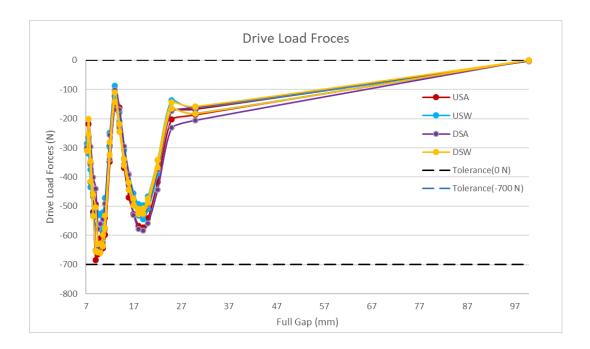


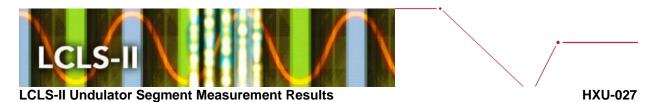
Undulator Gap Difference



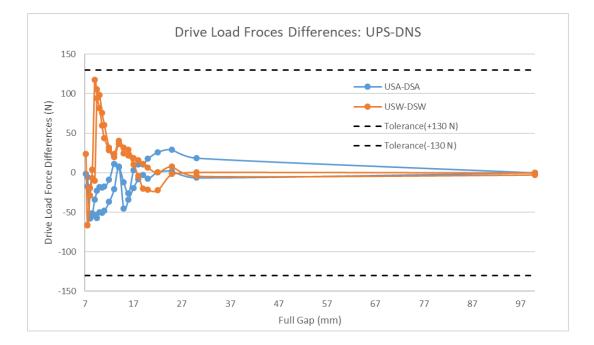


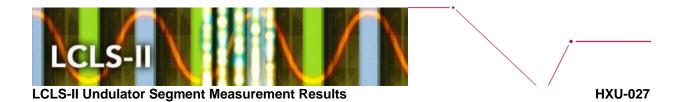
Drive Loads (Gap Opening)



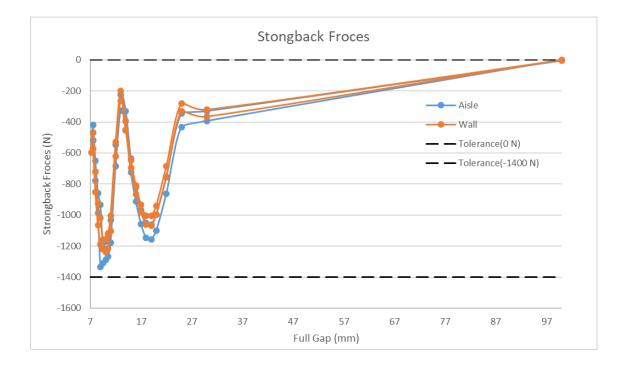


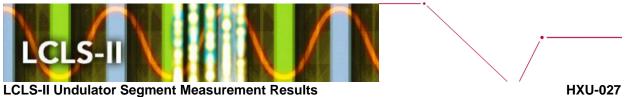
Drive Load Differences (Gap Opening - Closing)





Strongback Forces (Gap Opening and Closing)





Strongback Force Differences (Gap Closing - Opening)

